

Notice of References Cited	Application/Control No. 10/768,345		Applicant(s)/Patent Under Reexamination SPILMAN ET AL.	
	Examiner Tae H. Yoon		Art Unit 1714	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,306,956	10-2001	Spilman et al.	524/601
	B	US-			
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	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	NL 8304021 A	12-1984	Netherland		
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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